A Tutorial on Stochastic Models and Statistical Analysis for Frequency Stability Measurements

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Introduction

- time scales limited by clock noise
- can model clock noise as stochastic process $\{X_t\}$
	- **–** set of random variables (RVs) indexed by t
	- $-X_t$ represents clock noise at time t
	- **–** will concentrate on sampled data, for which will take $t \in \mathbb{Z} \equiv \{\ldots, -1, 0, 1, \ldots\}$ (but sometimes use $t \in \mathbb{Z}^* \equiv \{0, 1, 2, \ldots\}$)
- Q: which stochastic processes are useful models?
- Q: how can we deduce model parameters & other characteristics from observed data?
- will cover the following in this tutorial:
	- **–** stationary processes & closely related processes
	- **–** fractionally differenced & related processes
	- **–** two analysis of variance ('power') techniques
		- ∗ spectral analysis
		- ∗ wavelet analysis
	- **–** parameter estimation via analysis techniques

Stationary Processes: I

- stochastic process $\{X_t\}$ called stationary if
	- $-E{X_t} = \mu_X$ for all t; i.e., a constant that does not depend on \boldsymbol{t}
	- $-\text{cov}\{X_t, X_{t+\tau}\} = s_{X,\tau}$, all possible $t \& t + \tau$; i.e., depends on lag τ , but not t
- $\{s_{X,\tau} : \tau \in \mathbb{Z}\}\$ is autocovariance sequence (ACVS)
- $s_{X,0} = \text{cov}\{X_t, X_t\} = \text{var}\{X_t\};$ i.e., process variance is constant for all t
- spectral density function (SDF) given by

$$
S_X(f) = \sum_{\tau = -\infty}^{\infty} s_{X,\tau} e^{-i2\pi f \tau}, \quad |f| \le 1/2
$$

note: $S_X(-f) = S_X(f)$ for real-valued processes

Stationary Processes: II

• if
$$
\{X_t\}
$$
 has SDF $S_X(\cdot)$, then

$$
\int_{-1/2}^{1/2} S_X(f) e^{i2\pi f \tau} df = s_{X,\tau}, \quad \tau \in \mathbb{Z}
$$

• setting $\tau = 0$ yields fundamental result:

$$
\int_{-1/2}^{1/2} S_X(f) \, df = s_{X,0} = \text{var} \, \{X_t\};
$$

i.e., SDF decomposes var $\{X_t\}$ across frequencies f

 \bullet if $\{a_u\}$ is a filter, then (with 'matching condition')

$$
Y_t \equiv \sum_{u=-\infty}^{\infty} a_u X_{t-u}
$$

is stationary with SDF given by

$$
S_Y(f) = \mathcal{A}(f)S_X(f), \text{ where } \mathcal{A}(f) \equiv \left| \sum_{u = -\infty}^{\infty} a_u e^{-i2\pi fu} \right|^2
$$

• if ${a_u}$ narrow-band of bandwidth Δf about f , i.e.,

$$
\mathcal{A}(f') = \begin{cases} \frac{1}{2\Delta f}, & f - \frac{\Delta f}{2} \le |f'| \le f + \frac{\Delta f}{2} \\ 0, & \text{otherwise,} \end{cases}
$$

then have following interpretation for $S_X(f)$:

$$
\text{var}\left\{Y_t\right\} = \int_{-1/2}^{1/2} S_Y(f') \, df' = \int_{-1/2}^{1/2} \mathcal{A}(f') S_X(f') \, df' \approx S_X(f)
$$

White Noise Process

- simplest stationary process is white noise
- \bullet $\{\epsilon_t\}$ is white noise process if
	- $-E{\epsilon_t} = \mu_{\epsilon}$ for all t (usually take $\mu_{\epsilon} = 0$) $-$ var $\{\epsilon_t\} = \sigma_{\epsilon}^2$ for all t $-\text{cov}\left\{\epsilon_t, \epsilon_{t'}\right\} = 0 \text{ for all } t \neq t'$
- white noise thus stationary with ACVS

$$
s_{\epsilon,\tau} = \text{cov}\left\{\epsilon_t, \epsilon_{t+\tau}\right\} = \begin{cases} \sigma_{\epsilon}^2, & \tau = 0; \\ 0, & \text{otherwise,} \end{cases}
$$

and SDF

$$
S_{\epsilon}(f) = \sum_{\tau = -\infty}^{\infty} s_{X,\tau} e^{-i2\pi f \tau} = \sigma_{\epsilon}^2
$$

Backward Differences of White Noise

• consider first order backward difference of white noise:

$$
X_t = \epsilon_t - \epsilon_{t-1} = \sum_{u=-\infty}^{\infty} a_u \epsilon_{t-u} \text{ with } a_u \equiv \begin{cases} 1, & u = 0; \\ -1, & u = 1; \\ 0, & \text{otherwise.} \end{cases}
$$

- have $S_X(f) = \mathcal{A}(f)S_{\epsilon}(f) = |2\sin(\pi f)|^2 \sigma_{\epsilon}^2 \approx |2\pi f|^2 \sigma_{\epsilon}^2$ at low frequencies (using $sin(x) \approx x$ for small x)
- let B be backward shift operator: $B\epsilon_t = \epsilon_{t-1}$, $B^2\epsilon_t = \epsilon_{t-2}$, $(1 - B)\epsilon_t = \epsilon_t - \epsilon_{t-1}$, etc.
- consider dth order backward difference of white noise:

$$
X_t = (1 - B)^d \epsilon_t = \sum_{k=0}^d \binom{d}{k} (-1)^k \epsilon_{t-k}
$$

=
$$
\sum_{k=0}^d \frac{d!}{k!(d-k)!} (-1)^k \epsilon_{t-k}
$$

=
$$
\sum_{k=0}^\infty \frac{\Gamma(1-\delta)}{\Gamma(k+1)\Gamma(1-\delta-k)} (-1)^k \epsilon_{t-k}
$$

with $s = d$ is a $s = 1, 2$

with $\delta \equiv -d$, i.e., $\delta = -1, -2, \ldots$

• SDF given by

$$
S_X(f) = \mathcal{A}(f)S_{\epsilon}(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}} \approx \frac{\sigma_{\epsilon}^2}{|2\pi f|^{2\delta}}
$$

Fractional Differences of White Noise

• for δ not necessary an integer,

$$
X_t = \sum_{k=0}^{\infty} \frac{\Gamma(1-\delta)}{\Gamma(k+1)\Gamma(1-\delta-k)} (-1)^k \epsilon_{t-k} \equiv \sum_{k=0}^{\infty} a_k(\delta) \epsilon_{t-k}
$$

makes sense as long as $\delta < 1/2$

- $\{X_t\}$ stationary fractionally differenced (FD) process
- SDF is as before:

$$
S_X(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}} \approx \frac{\sigma_{\epsilon}^2}{|2\pi f|^{2\delta}}
$$

• $\{X_t\}$ said to obey power law at low frequencies if

$$
\lim_{f \to 0} \frac{S_X(f)}{C|f|^\alpha} = 1
$$

for $C > 0$; i.e., $S_X(f) \approx C|f|^{\alpha}$ at low frequencies

- FD processes obey above with $\alpha = -2\delta$
- note: FD process reduces to white noise when $\delta = 0$

ACVS & PACS for FD Processes

• for
$$
\delta < 1/2
$$
 & $\delta \neq 0, -1, \ldots$, ACVS given by
\n
$$
s_{X,\tau} = \sigma_{\epsilon}^2 \frac{\sin(\pi \delta) \Gamma(1 - 2\delta) \Gamma(\tau + \delta)}{\pi \Gamma(1 + \tau - \delta)};
$$
\nwhen $\delta = 0, -1, \ldots$, have $s_{X,\tau} = 0$ for $|\tau| > -\delta$ &
\n
$$
s_{X,\tau} = \sigma_{\epsilon}^2 \frac{(-1)^{\tau} \Gamma(1 - 2\delta)}{\Gamma(1 + \tau - \delta) \Gamma(1 - \tau - \delta)}, \quad 0 \leq |\tau| \leq -\delta
$$

• for all $\delta < 1/2$, have

$$
s_{X,0} = \text{var}\left\{X_t\right\} = \sigma_\epsilon^2 \frac{\Gamma(1-2\delta)}{\Gamma^2(1-\delta)},
$$

and rest of ACVS can be computed easily via

$$
s_{X,\tau} = s_{X,\tau-1} \frac{\tau + \delta - 1}{\tau - \delta}, \quad \tau \in \mathbb{Z}^+ \equiv \{1, 2, ...\}
$$

(for negative lags τ , recall that $s_{X,-\tau} = s_{X,\tau}$).

• for all δ < 1/2, partial autocorrelation sequence (PACS) given by

$$
\phi_{t,t} \equiv \frac{\delta}{t-\delta}, \quad t \in \mathbb{Z}^+
$$

(useful for constructing best linear predictors)

• FD processes thus have simple and easily computed expressions for SDF, ACVS and PACS

Simulating Stationary FD Processes

- for $-1 \leq \delta < 1/2$, can obtain exact simulations via 'circulant embedding' (Davies–Harte algorithm)
- given $s_{X,0},\ldots,s_{X,N}$, use discrete Fourier transform (DFT) to compute

$$
S_k \equiv \sum_{\tau=0}^N s_{X,\tau} e^{-i2\pi f_k \tau} + \sum_{\tau=N+1}^{2N-1} s_{X,2N-\tau} e^{-i2\pi f_k \tau}, \quad k=0,\ldots,N
$$

• given $2N$ independent Gaussian deviates ε_t with mean zero and variance σ_{ϵ}^2 , compute

$$
\mathcal{Y}_k \equiv \begin{cases} \varepsilon_0 \sqrt{2NS_0}, & k = 0; \\ (\varepsilon_{2k-1} + i\varepsilon_{2k}) \sqrt{NS_k}, & 1 \le k < N; \\ \varepsilon_{2N-1} \sqrt{2NS_N}, & k = N; \\ \mathcal{Y}_{2N-k}^*, & N < k \le 2N - 1; \end{cases}
$$

(asterisk denotes complex conjugate)

• use inverse DFT to construct the real-valued sequence

$$
Y_t = \frac{1}{2N} \sum_{k=0}^{2N-1} \mathcal{Y}_k e^{i2\pi f_k t}, \quad t = 0, \dots, 2N-1
$$

- $Y_0, Y_1, \ldots, Y_{N-1}$ is exact simulation of FD process
- implication: can represent $X_0, X_1, \ldots, X_{N-1}$ as $X_t = \sum_{i=1}^{2N-1}$ −1 $k=0$ $c_{t,k}(\delta)\varepsilon_k$ rather than $X_t = \sum_{k=1}^{\infty}$ $k=0$ $a_k(\delta)\epsilon_{t-k}$

Nonstationary FD Processes: I

- suppose $X_t^{(1)}$ is FD process with parameter $\delta^{(s)}$ such that $-1/2 \leq \delta^{(s)} < 1/2$
- define $X_t, t \in \mathbb{Z}^*$, as cumulative sum of $X_t^{(1)}, t \in \mathbb{Z}^*$:

$$
X_t \equiv \sum_{l=0}^t X_l^{(1)}
$$

(for $l < 0$, let $X_t \equiv 0$)

• since, for $t \in \mathbb{Z}^*$,

$$
X_t^{(1)} = X_t - X_{t-1} \& S_{X^{(1)}}(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta^{(s)}}},
$$

filtering theory suggests using relationship

$$
S_{X^{(1)}}(f) = |2\sin(\pi f)|^2 S_X(f)
$$

to *define* SDF for X_t , i.e.,

$$
S_X(f) = \frac{S_{X^{(1)}}(f)}{|2\sin(\pi f)|^2} = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}}
$$

with $\delta \equiv \delta^{(s)} + 1$ (Yaglom, 1958)

Nonstationary FD Processes: II

- X_t has stationary 1st order backward differences
- \bullet 1 sum defines FD processes for $1/2 \leq \delta < 3/2$
- \bullet 2 sums define FD processes for $3/2 \leq \delta < 5/2,$ etc
- X_t has stationary 2nd order backward differences, etc
- if $X_t^{(1)}$ is white noise $(\delta^{(s)} = 0)$ so $S_{X^{(1)}}(f) = \sigma_{\epsilon}^2$, then X_t is random walk $(\delta = 1)$ with

$$
S_X(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^2} \approx \frac{\sigma_{\epsilon}^2}{|2\pi f|^2}
$$

• if $X_t^{(2)}$ is white noise and if

$$
X_t^{(1)} \equiv \sum_{l=0}^t X_l^{(2)} \& X_t \equiv \sum_{l=0}^t X_l^{(1)}, \quad t \in \mathbb{Z}^*,
$$

then X_t is random run $(\delta = 2)$, and

$$
S_X(f) \approx \frac{\sigma_{\epsilon}^2}{|2\pi f|^4}
$$

Summary of FD Processes

• X_t said to be FD process if its SDF is given by

$$
S_X(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}} \approx \frac{\sigma_{\epsilon}^2}{|2\pi f|^{2\delta}}
$$
 at low frequencies

- well-defined for any real-valued δ
- FD process obeys power law at low frequencies with exponent $\alpha = -2\delta$
- if $\delta < 1/2$, FD process stationary with

– ACVS given by

$$
s_{X,0} = \sigma_{\epsilon}^2 \frac{\Gamma(1 - 2\delta)}{\Gamma^2(1 - \delta)} \& s_{X,\tau} = s_{X,\tau-1} \frac{\tau + \delta - 1}{\tau - \delta}, \quad \tau \in \mathbb{Z}^+
$$

– PACS given by

$$
\phi_{t,t} \equiv \frac{\delta}{t-\delta}, \quad t \in \mathbb{Z}^+
$$

• if $\delta \geq 1/2$, FD process nonstationary but its dth order backward difference is stationary FD process with parameter $\delta^{(s)}$, where

$$
d \equiv \lfloor \delta + 1/2 \rfloor
$$
 and $\delta^{(s)} \equiv \delta - d$

(here $\lfloor x \rfloor$ is largest integer $\leq x$)

Alternatives to FD Processes: I

• fractional Brownian motion (FBM)

 $-B_H(t), 0 \le t < \infty$, has SDF given by

$$
S_{B_H(t)}(f) = \frac{\sigma_X^2 C_H}{|f|^{2H+1}}, \quad -\infty < f < \infty,
$$

where $\sigma_X^2 > 0, C_H > 0 \& 0 < H < 1$ (*H* called Hurst parameter; C_H depends on H)

– power law with $-3 < \alpha < -1$

- discrete fractional Brownian motion (DFBM)
	- $-B_t, t \in \mathbb{Z}^+$, is DFBM if $B_t = B_H(t)$
	- $-B_t$ has SDF given by

$$
S_{B_t}(f) = \sigma_X^2 C_H \sum_{j=-\infty}^{\infty} \frac{1}{|f+j|^{2H+1}}, \quad |f| \le 1/2
$$

– power law at low frequencies with $-3 < \alpha < -1$

– reduces to random walk if $H = 1/2$

Alternatives to FD Processes: II

• fractional Gaussian noise (FGN)

$$
-X_t, t \in \mathbb{Z}^+, \text{ is FCN if } X_t = B_{t+1} - B_t
$$

 $-X_t$ has SDF given by

$$
S_X(f) = 4\,\sigma_X^2 C_H \sin^2(\pi f) \sum_{j=-\infty}^{\infty} \frac{1}{|f+j|^{2H+1}}, \quad |f| \le 1/2
$$

- power law at low frequencies with $-1 < \alpha < 1$
- $-X_t$ is stationary, with ACVS given by

$$
s_{X,\tau} = \frac{\sigma_X^2}{2} \left(|\tau + 1|^{2H} - 2|\tau|^{2H} + |\tau - 1|^{2H} \right), \quad \tau \in \mathbb{Z},
$$

where $\sigma_X^2 = \text{var}\{X_t\}$

– reduces to white noise if $H = 1/2$

• discrete pure power law (PPL) process

- $-$ SDF given by $S_X(f) = C_S|f|^\alpha$, $|f| \leq 1/2$
- $-$ if α > -1 , stationary, but ACVS takes some effort to compute
- if $\alpha = 0$, reduces to white noise
- **–** α ≤ −1, nonstationary but backward differences of certain order are stationary

FD Processes vs. Alternatives

- FD processes cover full range of power laws
	- **–** FBMs, DFBMs and FGNs cover limited range
	- **–** PPL processes also cover full range
- differencing FD process yields another FD process; differencing alternatives yields new type of process
- FD process has simple SDF; if stationary, has simple ACVS & PACS
	- **–** FBM has simple SDF
	- **–** DFBM has complicated SDF
	- **–** FGN has simple ACVS, complicated SDF & PACS
	- **–** PPL has simple SDF, complicated ACVS & PACS
- FD, DFBM, FGN and PPL model sampled noise
	- **–** might be problematic to change sampling rate
	- **–** FBM models unsampled noise
- Fig. 1: comparison of SDFs for FGN, PPL & FD
- Fig. 2: comparison of realizations

Extensions to FD Processes: I

• composite FD processes

$$
S_X(f) = \sum_{m=1}^M \frac{\sigma_m^2}{|2\sin(\pi f)|^{2\delta_m}};
$$

i.e., linear combinations of independent FD processes

- autoregressive, fractionally integrated, moving average (ARFIMA) processes
	- idea is to replace ϵ_t in

$$
X_t = \sum_{k=0}^{\infty} a_k(\delta) \epsilon_{t-k}
$$

with ARMA process, say,

$$
U_t = \sum_{k=1}^p \phi_k U_{t-k} + \epsilon_t - \sum_{k=1}^q \theta_k \epsilon_{t-k}
$$

– yields process with SDF

$$
S_X(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}} \cdot \frac{|1 - \Sigma_{k=1}^q \theta_k e^{-i2\pi f k}|^2}{|1 - \Sigma_{k=1}^p \phi_k e^{-i2\pi f k}|^2}
$$

– ARMA part can model, e.g., high-frequency structure in noise

Extensions to FD Processes: II

• can define time-varying FD (TVFD) process via

$$
X_t = \sum_{k=0}^{\infty} a_k(\delta_t) \epsilon_{t-k}
$$

as long as $\delta_t < 1/2$ for all t

– can use representation

$$
X_t = \sum_{k=0}^{2N-1} c_{t,k}(\delta_t) \varepsilon_k, \quad t = 0, 1, \dots, N-1,
$$

to extend definition to handle arbitrary δ_t

– Fig. 3: realizations from 4 TVFD processes

 $-$ can also make σ_{ϵ}^2 time-varying

FD Process Parameter Estimation

- Q: given realization (clock noise) of X_0, \ldots, X_{N-1} from FD process, how can we estimate $\delta \& \sigma_{\epsilon}^2$?
- many different estimators have been proposed! (area of active research)
- will concentrate on estimators based on
	- **–** spectral analysis (frequency-based)
	- **–** wavelet analysis (scale-based)
- advantages of spectral and wavelet analysis
	- **–** physically interpretable
	- **–** both are analysis of variance techniques (useful for more than just estimating $\delta \& \sigma_{\epsilon}^2$)
	- **–** can assess need for models more complex than simple FD process (e.g., composite FD process)
	- **–** provide preliminary estimates for more complicated schemes (maximum likelihood estimation)

Estimation via Spectral Analysis

• recall that SDF for FD process given by

$$
S_X(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}}
$$

and thus

$$
\log(S_X(f)) = \log(\sigma_{\epsilon}^2) - 2\delta \log(|2\sin(\pi f)|);
$$

i.e., plot of $\log(S_X(f))$ vs. $\log(|2\sin(\pi f)|)$ linear with slope of -2δ

• for $0 < f < 1/8$, have $\sin(\pi f) \approx \pi f$, so

$$
\log(S_X(f)) \approx \log(\sigma_{\epsilon}^2) - 2\delta \log(2\pi f);
$$

i.e., plot of $\log(S_X(f))$ vs. $\log(2\pi f)$ approximately linear at low frequencies with slope of $-2\delta = \alpha$

- basic scheme
	- estimate $S_X(f)$ via $\hat{S}_X(f)$
	- fit linear model to $\hat{S}_X(f)$ vs. $\log(2\pi f)$ over low frequencies
	- use estimated slope $\hat{\alpha}$ to estimate δ via $-\hat{\alpha}/2$
	- use estimated intercept to estimate σ_{ϵ}^2

The Periodogram: I

• basic estimator of $S(f)$ is periodogram:

$$
\hat{S}^{(p)}(f) \equiv \frac{1}{N} \left| \sum_{t=0}^{N-1} X_t e^{-i2\pi ft} \right|^2, \qquad |f| \le 1/2;
$$

• represents decomposition of sample variance:

$$
\int_{-1/2}^{1/2} \hat{S}^{(p)}(f) df = \frac{1}{N} \sum_{t=0}^{N-1} X_t^2
$$

• for stationary processes $\&$ large N , theory says

$$
\hat{S}^{(p)}(f) \stackrel{\text{d}}{=} S(f)\frac{\chi_2^2}{2}, \quad 0 < f < 1/2,
$$

approximately, implying that

 $-E\{\hat{S}^{(p)}(f)\}\approx E\{S(f)\chi_2^2/2\}=S(f)$ $-$ var $\{\hat{S}^{(p)}(f)\}\approx \text{var}\{S(f)\chi_2^2/2\}=S^2(f)$

(in above $\left(\frac{d}{dx} \right)$ means 'equal in distribution,' and χ^2 is chi-square RV with 2 degrees of freedom)

• additionally, $cov \{\hat{S}^{(p)}(f_j), \hat{S}^{(p)}(f_k)\} \approx 0$ for $f_i \equiv j/N \& 0 < f_i < f_k < 1/2$

The Periodogram: II

• taking log transform yields

$$
\log\left(\hat{S}^{(p)}(f)\right) \stackrel{\text{d}}{=} \log\left(S(f)\frac{\chi_2^2}{2}\right) = \log\left(S(f)\right) + \log\left(\frac{\chi_2^2}{2}\right)
$$

 \bullet Bartlett & Kendall (1946):

$$
E\left\{\log\left(\frac{\chi_{\eta}^{2}}{\eta}\right)\right\} = \psi(\eta) - \log(\eta) \& \text{var}\left\{\log\left(\frac{\chi_{\eta}^{2}}{\eta}\right)\right\} = \psi'(\eta)
$$

where $\psi(\cdot) \& \psi'(\cdot)$ are di- & trigamma functions

 \bullet yields

$$
E\{\log(\hat{S}^{(p)}(f))\} = \log(S(f)) + \psi(2) - \log(2)
$$

$$
= \log(S(f)) - \gamma
$$

$$
\text{var}\{\log(\hat{S}^{(p)}(f))\} = \psi'(2) = \pi^2/6
$$

$$
(\gamma \doteq 0.57721 \text{ is Euler's constant})
$$

The Periodogram: III

- define $Y^{(p)}(f_j) \equiv \log (\hat{S}^{(p)}(f_j)) + \gamma$
- can model $Y^{(p)}(f_j)$ as

$$
Y^{(p)}(f_j) \approx \log (S(f_j)) + \epsilon(f_j)
$$

$$
\approx \log (\sigma_{\epsilon}^2) - 2\delta \log (2\pi f_j) + \epsilon(f_j)
$$

over low frequencies indexed by $0 < j < J$

- error $\epsilon(f_j)$ in linear regression model such that
	- $-E{\epsilon(f_j)} = 0$ & var ${\epsilon(f_j)} = \pi^2/6$ (known!)
	- $-$ if $\{X_t\}$ Gaussian & $\hat{S}^{(p)}(f_j)$'s uncorrelated, then $\epsilon(f_i)$'s pairwise uncorrelated
	- $-\epsilon(f_j) \stackrel{\text{d}}{=} \log(\chi_2^2)$ markedly non-Gaussian
- least squares procedure yields
	- $-$ estimates $\hat{\delta}$ and $\hat{\sigma}_{\epsilon}^2$ for δ and σ_{ϵ}^2
	- estimates of variability in $\hat{\delta}$ and $\hat{\sigma}_{\epsilon}^2$

Multitaper Spectral Estimation: I

- warnings about periodogram:
	- **–** approximations might require N to be very large!
	- **–** approximations of questionable validity for nonstationary FD processes
- Fig. 4: periodogram can suffer from 'leakage'
- tapering is technique for alleviating leakage:

$$
\hat{S}^{(d)}(f) \equiv \left| \sum_{t=0}^{N-1} a_t X_t e^{-i2\pi ft} \right|^2
$$

 $-$ { a_t } called data taper (typically bell-shaped curve)

$$
-\hat{S}^{(d)}(\cdot)
$$
 called direct spectral estimator

- critique: loses 'information' at end of series (sample size N effectively shortened)
- Thomson (1982): multitapering recovers 'lost info'
- use set of K orthonormal data tapers $\{a_{n,t}\}$:

$$
\sum_{t=0}^{N-1} a_{n,t} a_{l,t} = \begin{cases} 1, & \text{if } n = l; \\ 0, & \text{if } n \neq l. \end{cases} \quad 0 \le n, l \le K - 1
$$

Multitaper Spectral Estimation: II

 \bullet use $\{a_{n,t}\}$ to form $k\text{th}$ direct spectral estimator:

$$
\hat{S}_k^{(mt)}(f) \equiv \left| \sum_{t=0}^{N-1} a_{n,t} X_t e^{-i2\pi ft} \right|^2, \quad n = 0, \dots, K-1
$$

• simplest form of multitaper SDF estimator:

$$
\hat{S}^{(mt)}(f) \equiv \frac{1}{K} \sum_{n=0}^{K-1} \hat{S}_n^{(mt)}(f)
$$

• sinusoidal tapers are one family of multitapers:

$$
a_{n,t} = \left\{ \frac{2}{(N+1)} \right\}^{1/2} \sin \left\{ \frac{(n+1)\pi(t+1)}{N+1} \right\}, \quad t = 0, \dots, N-1
$$

(Riedel & Sidorenko, 1995)

- Figs. 5 and 6: example of multitapering
- \bullet if $S(\cdot)$ slowly varying around $S(f)$ & if N large,

$$
\hat{S}^{(mt)}(f) \stackrel{\text{d}}{=} \frac{S(f)\chi_{2K}^2}{2K}
$$

approximately for $0 < f < 1/2,$ impling

$$
\text{var}\{\hat{S}^{(mt)}(f)\} \approx \frac{S^2(f)}{4K^2} \text{var}\{\chi_{2K}^2\} = \frac{S^2(f)}{K}
$$

Multitaper Spectral Estimation: III

- define $Y^{(mt)}(f_j) \equiv \log (\hat{S}^{(mt)}(f_j)) \psi(K) + \log(K)$
- can model $Y^{(mt)}(f_j)$ as

$$
Y^{(mt)}(f_j) \approx \log (S(f_j)) + \eta(f_j)
$$

$$
\approx \log (\sigma_{\epsilon}^2) - 2\delta \log (2\pi f_j) + \eta(f_j)
$$

over low frequencies indexed by $0 < j < J$

- error $\eta(f_i)$ in linear regression model such that
	- $-E{\eta(f_i)}=0$
	- $-$ var $\{\eta(f_j)\} = \psi'(K)$, a known constant!
	- approximately Gaussian if $K \geq 5$
	- **–** correlated, but with simple structure:

$$
cov{\eta(f_j), \eta(f_{j+\nu})\} \approx \begin{cases} \psi'(K) \left(1 - \frac{|\nu|}{K+1}\right), & \text{if } |\nu| \le K+1; \\ 0, & \text{otherwise.} \end{cases}
$$

- generalized least squares procedure yields
	- $-$ estimates $\hat{\delta}$ and $\hat{\sigma}_{\epsilon}^2$ for δ and σ_{ϵ}^2
	- estimates of variability in $\hat{\delta}$ and $\hat{\sigma}_{\epsilon}^2$
- multitaper approach superior to periodogram approach

Discrete Wavelet Transform (DWT)

- let $\mathbf{X} = [X_0, X_1, \dots, X_{N-1}]^T$ be observed time series (for convenience, assume N integer multiple of 2^{J_0})
- let W be $N \times N$ orthonormal DWT matrix
- $W = \mathcal{W}X$ is vector of DWT coefficients
- orthonormality says $\mathbf{X} = \mathcal{W}^T \mathbf{W}$, so $\mathbf{X} \Leftrightarrow \mathbf{W}$
- can partition **W** as follows:

$$
\mathbf{W} = \begin{bmatrix} \mathbf{W}_1 \\ \vdots \\ \mathbf{W}_{J_0} \\ \mathbf{V}_{J_0} \end{bmatrix}
$$

- \mathbf{W}_j contains $N_j = N/2^j$ wavelet coefficients
	- related to changes of averages at scale $\tau_j = 2^{j-1}$ $(\tau_i$ is jth 'dyadic' scale)
	- related to times spaced 2^j units apart
- V_{J_0} contains $N_{J_0} = N/2^{J_0}$ scaling coefficients
	- related to averages at scale $\lambda_{J_0} = 2^{J_0}$
	- related to times spaced 2^{J_0} units apart

Example: Haar DWT

- Fig. 7: W for Haar DWT with $N = 16$
	- **–** first 8 rows yield **W**¹ ∝ changes on scale 1
	- **–** next 4 rows yield **W**² ∝ changes on scale 2
	- **–** next 2 rows yield **W**³ ∝ changes on scale 4
	- **–** next to last row yields **W**⁴ ∝ change on scale 8
	- **–** last row yields **V**⁴ ∝ average on scale 16
- Fig. 8: Haar DWT coefficients for clock 571

DWT in Terms of Filters

- filter $X_0, X_1, \ldots, X_{N-1}$ to obtain $2^{j/2}\widetilde{W}_{j,t}\equiv$ L - *j*−1 $l=0$ $h_{j,l}X_{t-l \bmod N}, \quad t = 0, 1, \ldots, N-1;$ $h_{j,l}$ is jth level wavelet filter (note: circular filtering)
- subsample to obtain wavelet coefficients:

 $W_{j,t} = 2^{j/2} \widetilde{W}_{j,2^j(t+1)-1}, \quad t = 0, 1, \ldots, N_j - 1,$ where $W_{j,t}$ is the element of \mathbf{W}_j

- Figs. $9 \& 10$: four sets of wavelet filters
- *j*th wavelet filter is band-pass with pass-band $\left[\frac{1}{2^{j+1}}, \frac{1}{2^j}\right]$ (i.e., scale related to interval of frequencies)
- similarly, scaling filters yield V_{J_0}
- Figs. 11 $\&$ 12: four sets of scaling filters
- J_0 th scaling filter is low-pass with pass-band $[0, \frac{1}{2^{J_0+1}}]$
- as width L of 1st level filters increases,
	- **–** band-pass & low-pass approximations improve
	- **–** # of embedded differencing operations increases (related to $#$ of 'vanishing moments')

DWT-Based Analysis of Variance

• consider 'energy' in time series:

$$
\|\mathbf{X}\|^2 = \mathbf{X}^T \mathbf{X} = \sum_{t=0}^{N-1} X_t^2
$$

 \bullet energy preserved in DWT coefficients:

$$
\|\mathbf{W}\|^2 = \|\mathcal{W}\mathbf{X}\|^2 = \mathbf{X}^T \mathcal{W}^T \mathcal{W} \mathbf{X} = \mathbf{X}^T \mathbf{X} = \|\mathbf{X}\|^2
$$

• since $\mathbf{W}_1, \ldots, \mathbf{W}_{J_0}, \mathbf{V}_{J_0}$ partitions **W**, have

$$
\|\mathbf{W}\|^2 = \sum_{j=1}^{J_0} \|\mathbf{W}_j\|^2 + \|\mathbf{V}_{J_0}\|^2,
$$

leading to analysis of sample variance:

$$
\hat{\sigma}^2 \equiv \frac{1}{N} \sum_{t=0}^{N-1} X_t^2 = \frac{1}{N} \left(\sum_{j=1}^{J_0} ||\mathbf{W}_j||^2 + ||\mathbf{V}_{J_0}||^2 \right)
$$

• scale-based decomposition (cf. frequency-based)

Variation: Maximal Overlap DWT

• can eliminate downsampling and use

$$
\widetilde{W}_{j,t} \equiv \frac{1}{2^{j/2}} \sum_{l=0}^{L_j-1} h_{j,l} X_{t-l \bmod N}, \quad t = 0, 1, \dots, N-1
$$

to define MODWT coefficients \mathbf{W}_j ($\&$ also \mathbf{V}_j)

- unlike DWT, MODWT is not orthonormal (in fact MODWT is highly redundant)
- like DWT, can do analysis of variance because

$$
\|\mathbf{X}\|^2 = \sum_{j=1}^{J_0} \|\widetilde{\mathbf{W}}_j\|^2 + \|\widetilde{\mathbf{V}}_{J_0}\|^2
$$

- unlike DWT, MODWT works for all samples sizes N (i.e., power of 2 assumption is not required)
- Fig. 13: Haar MODWT coefficients for clock 571 (cf. Fig. 8 with DWT coefficients)
- can use to track time-varying FD process

Definition of Wavelet Variance

- let X_t , $t \in \mathbb{Z}$, be a stochastic process
- run X_t through jth level wavelet filter:

$$
\overline{W}_{j,t} \equiv \sum_{l=0}^{L_j-1} \tilde{h}_{j,l} X_{t-l}, \quad t \in \mathbb{Z}
$$

• definition of time dependent wavelet variance (also called wavelet spectrum):

$$
\nu_{X,t}^2(\tau_j) \equiv \text{var}\,\{\overline{W}_{j,t}\},\
$$

assuming var $\{\overline{W}_{j,t}\}$ exists and is finite

- $\nu^2_{X,t}(\tau_j)$ depends on τ_j and t
- will consider time independent wavelet variance:

$$
\nu_X^2(\tau_j) \equiv \text{var}\left\{\overline{W}_{j,t}\right\}
$$

(can be easily adapted to time varying situation)

- rationale for wavelet variance
	- **–** decomposes variance on scale by scale basis
	- **–** useful substitute/complement for SDF

Variance Decomposition

• suppose X_t has SDF $S_X(f)$:

$$
\int_{-1/2}^{1/2} S_X(f) \, df = \text{var} \, \{X_t\};
$$

i.e., decomposes var $\{X_t\}$ across frequencies f

- **–** involves uncountably infinite number of f's
- $-S_X(f) \Delta f \approx$ contribution to var $\{X_t\}$ due to f's in interval of length Δf centered at f
- note: var $\{X_t\}$ taken to be ∞ for nonstationary processes with stationary backward differences
- wavelet variance analog to fundamental result:

$$
\sum_{j=1}^{\infty} \nu_X^2(\tau_j) = \text{var}\{X_t\}
$$

i.e., decomposes var $\{X_t\}$ across scales τ_i

- **–** recall DWT/MODWT and sample variance
- involves countably infinite number of τ_j 's
- $-\nu_X^2(\tau_j)$ contribution to var $\{X_t\}$ due to scale τ_j
- $-\nu_X(\tau_j)$ has same units as X_t (easier to interpret)

Spectrum Substitute/Complement

• because $\tilde{h}_{j,l} \approx$ bandpass over $[1/2^{j+1}, 1/2^j]$,

$$
\nu_X^2(\tau_j) \approx 2 \int_{1/2^{j+1}}^{1/2^j} S_X(f) \, df \tag{*)}
$$

- if $S_X(f)$ 'featureless', info in $\nu_X^2(\tau_j) \Leftrightarrow$ info in $S_X(f)$
- $\nu_X^2(\tau_j)$ more succinct: only 1 value per octave band
- recall SDF for FD process:

$$
S_X(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}} \approx \frac{\sigma_{\epsilon}^2}{|2\pi f|^{2\delta}}
$$

- (*) implies $\nu_X^2(\tau_j) \propto \tau_j^{2\delta-1}$ approximately
- can deduce δ from slope of $\log(\nu_X^2(\tau_j))$ vs. $\log(\tau_j)$
- can estimate $\delta \& \sigma_{\epsilon}^2$ by applying regression analysis to log of estimates of $\nu_X^2(\tau_j)$

Estimation of Wavelet Variance: I

• can base estimator on MODWT of $X_0, X_1, \ldots, X_{N-1}$:

$$
\widetilde{W}_{j,t} \equiv \sum_{l=0}^{L_j-1} \widetilde{h}_{j,l} X_{t-l \bmod N}, \quad t = 0, 1, \ldots, N-1
$$

(DWT-based estimator possible, but less efficient)

• recall that

$$
\overline{W}_{j,t} \equiv \sum_{l=0}^{L_j-1} \tilde{h}_{j,l} X_{t-l}, \quad t = 0, \pm 1, \pm 2, \dots
$$

so $W_{j,t} = \overline{W}_{j,t}$ if mod not needed: $L_j - 1 \leq t < N$

• if $N - L_j \geq 0$, unbiased estimator of $\nu_X^2(\tau_j)$ is

$$
\hat{\nu}_X^2(\tau_j) \equiv \frac{1}{N - L_j + 1} \sum_{t = L_j - 1}^{N - 1} \widetilde{W}_{j,t}^2 = \frac{1}{M_j} \sum_{t = L_j - 1}^{N - 1} \overline{W}_{j,t}^2,
$$

where $M_j \equiv N - L_j + 1$

• can also construct biased estimator of $\nu_X^2(\tau_j)$:

$$
\tilde{\nu}_X^2(\tau_j) \equiv \frac{1}{N} \sum_{t=0}^{N-1} \widetilde{W}_{j,t}^2 = \frac{1}{N} \Big(\sum_{t=0}^{L_j - 2} \widetilde{W}_{j,t}^2 + \sum_{t=L_j - 1}^{N-1} \overline{W}_{j,t}^2 \Big)
$$

1st sum in parentheses influenced by circularity

Estimation of Wavelet Variance: II

- \bullet biased estimator unbiased if $\{X_t\}$ white noise
- biased estimator offers exact analysis of $\hat{\sigma}^2$; unbiased estimator need not
- \bullet biased estimator can have better mean square error (Greenhall *et al.*, 1999; need to 'reflect' X_t)

$\bf Statistical\ Properties\ of\ \hat{\nu}_X^2(\tau_j)$

- suppose $\{\overline{W}_{j,t}\}$ Gaussian, mean 0 & SDF $S_j(f)$
- suppose square integrability condition holds:

$$
A_j \equiv \int_{-1/2}^{1/2} S_j^2(f) \, df < \infty \ \& \ S_j(f) > 0
$$

(holds for FD process if L large enough)

- can show $\hat{\nu}_X^2(\tau_j)$ asymptotically normal with mean $\nu_X^2(\tau_j)$ & large sample variance $2A_j/M_j$
- can estimate A_j and use with $\hat{\nu}_X^2(\tau_j)$ to construct confidence interval for $\nu_X^2(\tau_j)$
- example
	- **−** Fig. 14: clock errors $X_t \equiv X_t^{(0)}$ along with differences $X_t^{(i)} \equiv X_t^{(i-1)} - X_{t-1}^{(i-1)}$ for $i = 1, 2$
	- $-$ Fig. 15: $\hat{\nu}_X^2(\tau_j)$ for clock errors

$$
- \text{ Fig. 16: } \hat{\nu}_{\overline{Y}}^2(\tau_j) \text{ for } \overline{Y}_t \propto X_t^{(1)}
$$

– Haar $\hat{\nu}_{\overline{Y}}^2(\tau_j)$ related to Allan variance $\sigma_{\overline{Y}}^2(2,\tau_j)$:

$$
\nu_{\overline{Y}}^2(\tau_j) = \frac{1}{2}\sigma_{\overline{Y}}^2(2,\tau_j)
$$

Summary

- fractionally differenced processes are
	- **–** able to cover all power laws
	- **–** easy to work with (SDF, ACVS & PACS simply expressed)
	- **–** extensible to composite, ARFIMA & time-varying processes
- spectral and wavelet analysis can provide
	- **–** estimates of parameters of FD processes
	- **–** decomposition of sample variance across
		- ∗ frequencies (in case of spectral analysis)
		- ∗ scales (in case of wavelet analysis)
	- **–** complementary analyses
- wavelet analysis has some advantages for clock noise
	- $-$ estimates $\delta \& \sigma_{\epsilon}^2$ somewhat better
	- **–** useful with time-varying noise process
	- **–** can deal with polynomial trends (not covered here)
	- $-$ results expressed in same units as X_t^2
- a big 'thank you' to conference organizers!